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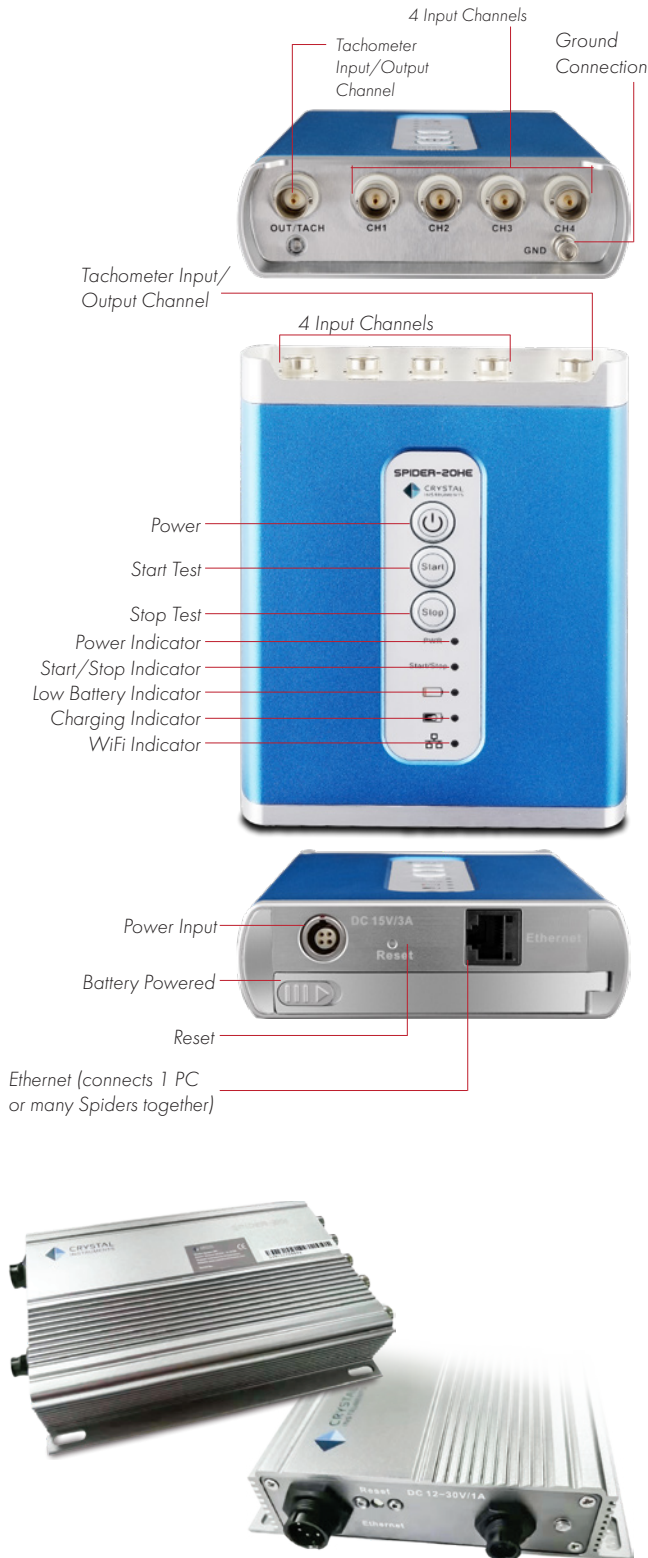
DYNAMIC SIGNAL ANALYSIS & DATA ACQUISITION

WWW.CRYSTALINSTRUMENTS.COM



Hardware Platforms

www.crystalinstruments.com/dynamic-measurement



Spider-20i Industrial Version

Spider-20 Handheld Dynamic Signal Analyzer Handheld Field Testing Solution

Spider-20 is a compact yet powerful dynamic signal analyzer and digital data recorder. It provides four 24-bit precise high-fidelity input channels, and a unique software-selectable tachometer-input/signal-source output channel (all using conventional BNC connectors). Each input is individually programmable to accept AC or DC voltage or output from an IEPE (ICP) sensor with built-in electronics.

Spider-20 is a diminutive 5.3 x 4.3 x 1 inch tool weighing only 18 ounces. It has only three push-button controls and five LED status indicators. This little powerhouse can run over 6 hours on its internal rechargeable battery which can be replaced in field with a backup battery. It can also record data on its built-in 4 GB flash memory at the simple push of a button.

Spider-20 communicates with the world through its built-in Ethernet connection. Link the Spider-20 to a laptop or tablet running Windows and enjoy the full repertoire of functionality provided by our EDM (Engineering Data Management) software including 1/nth Octave acoustic functions, Order Tracking for rotating machinery, Shock Response Spectra for drop testing, or Digital Filtering for special purpose analysis.

Transfer measured data to truly massive storage space using the EDM Cloud server. EDM can be used to program your Spider-20 to perform a custom measurement or measurement sequence at the touch of its START button, making it an unintimidating and user-friendly tool. No computer, tablet or phone is required; just use your thumb and your Spider-20 operating in Black Box mode.

Use our flexible Automated Schedule and Limiting software to turn this Spider into an intelligent unattended monitor capable of responding to data conditions or networked instructions, notifying you of significant conditions via e-mail.



Spider-20 & Spider-20i Features

- Weighs only 18 ounces
- Built-in Ethernet
- 4 GB Flash Memory
- Up to 256 kHz sampling rate
- 4 Input Channels
- 1 Tachometer Channel
- PC Independent
- 6 Hour Battery Life

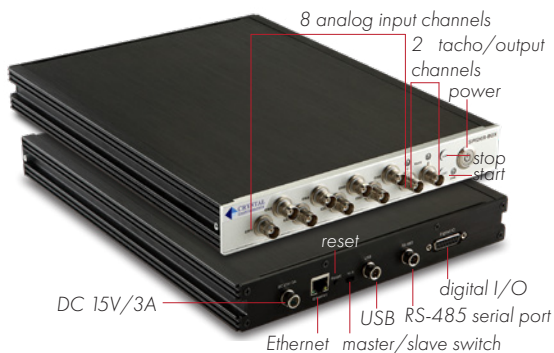
Industry and Product Applications

Machinery Diagnosis

Four inputs and a tachometer channel are the perfect size for many machinery monitoring tasks. Simultaneously measure two perpendicular proximity probes or horizontal and vertical bearing cap accelerations at both ends of a machine. Record this along with a 1/rev tachometer during startups and shutdowns to plot waterfalls and Campbell diagrams identifying resonances, critical speeds and unusual forcing functions. Use the same signal inputs to balance the machine. Place accelerometers on either side of a coupling to aid alignment.

Machine/Process Monitoring

Load a custom monitoring program employing our Automated Schedule and Limiting software and leave your Spider-20 to monitor speed and four dynamic inputs. Upon detecting an alarm-level limit (in the time or frequency domain), it can send you an email reporting the finding and make an immediate recording for more detailed analysis. For longer stays, leave the accessory AC power unit plugged in. This allows Spider-20 to draw power (6 Watts, maximum) from any 100 to 240 VAC (50/60 Hz) power line. Alternatively, you can provide a battery backup of 15 VDC ($\pm 10\%$) for more remote applications.



Spider-80X (front & back views)



64 Channel System (front & back views)

Spider-80X & Spider-80Xi Dynamic Measurement Systems

Expandable Systems: Up to 512 Channels

Spider-80X

The Spider-80X is designed for applications in three fields: dynamic data acquisition, vibration control, and machine monitoring. Each front-end features eight analog input channels and two channels that may be software selected as analog outputs for vibration control or tachometer inputs for the analysis of rotating machinery.

A single Spider-80X front-end is a complete two-output controller with the same high quality patented dual ADC input technology of the Spider-81 series. The Spider-80X inputs provide single-end/differential and AC/DC/IEPE coupling choices; charge mode is an available option that can be installed at the factory.

The Spider-80X also provides the same time sync Ethernet connectivity and 4 GB flash memory for data and program storage. Multiple Spider-80X front-ends may be linked together using the Spider-HUB Ethernet switch from Crystal Instruments. The data storage can be increased to 4 TB by adding a Spider-NAS mass storage device.

The Spider-80X front-ends are onsite swappable. Each front-end is metal-shielded. The user can quickly configure a system with an arbitrary number of front-ends.

Spider-80Xi

The Spider-80Xi is a compact version of Spider-80X with an extremely lightweight form factor. Featuring a 64-channel chassis weighing less than 10.5 kg, the Spider-80Xi can be carried in one hand and is optimal for field environment testing where portability is essential.

Multiple chassis combine to create a system up to 512 channels, all sampled simultaneously. A dedicated massive storage hard disk (a solid state hard-drive with a capacity of 250 GB, upgradable to 4 TB) allows the time signals of all input channels to record at up to 256 kHz/channel. Accurate time synchronization results in excellent phase match in the frequency domain between all channels, either on the same Spider front-end or across different front-ends. Real time FFT, octave, order tracking or vibration control functions can be enabled. The modular boards of the Spider-80Xi are installed at the factory and are not onsite swappable.

The Spider-80Xi system consisting of the 64-channel chassis is powered by AC power, at 100 to 240 VAC. The Spider-80Xi system consisting of the 32-channel chassis is powered by DC power, at 10 V to 22 V. The latter is also easily operable with an external battery pack. With the Spider-Battery (developed by Crystal Instruments), a 32-channel Spider-80Xi system operates for up to 4 hours without interruption.



Spider-HUB Industrial Ethernet Switch



Spider-NAS Network Attached Storage



Spider-80X Front-end



Spider-80SG Strain Gage Measurement System

Spider-80SG

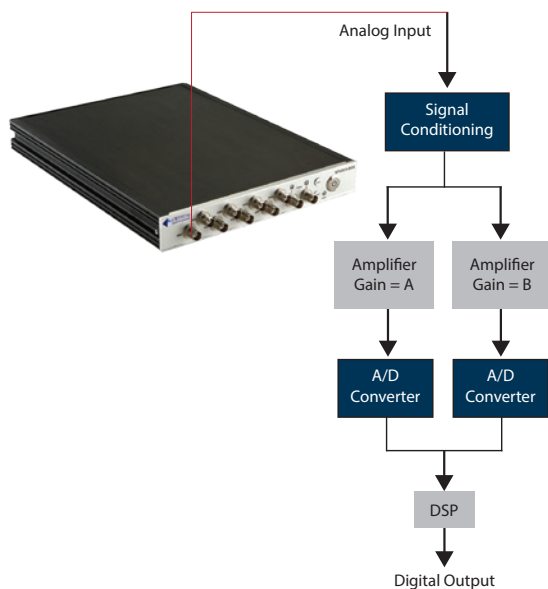
The Spider-80SG strain sensing device has the same mechanical form factor as the Spider-80X. These two systems can combine into a system that measures various dynamic signals, including strains or other sensors requiring excitation. Multiple Spider-80X or Spider-80SG front-ends can be hosted in a 64-input chassis.

Spider-HUB Ethernet Switch

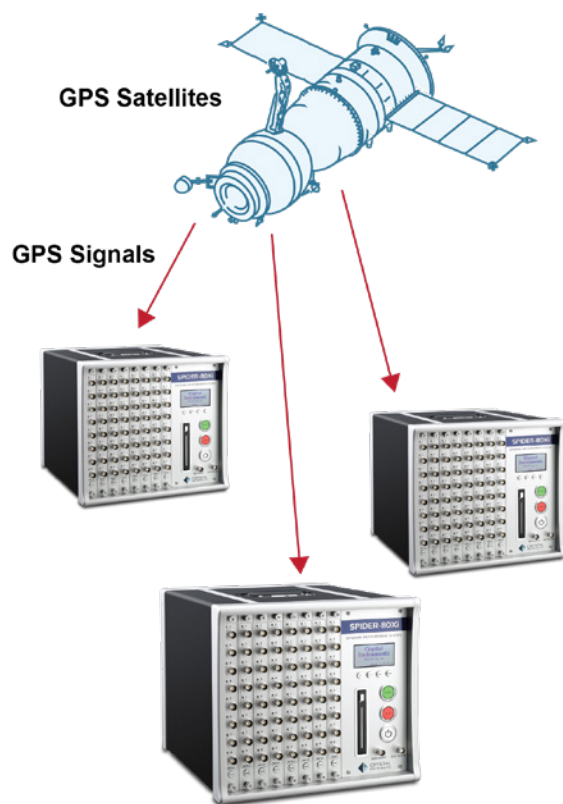
The Spider-HUB Ethernet switch made by Crystal Instruments supports the latest IEEE 1588v2 technology. The Spider-HUB guarantees time-stamping accuracy within 50 nanoseconds and can be configured for 1588v2 Master, Boundary Clock, and Transparent Clock functionality. Accurate phase match between all measurement channels across the modules are guaranteed. In a Spider-80Xi chassis the Spider-HUB is installed internally.

Spider-NAS Storage Device

The Spider-NAS (Network Attached Storage) is a dedicated storage device designed to work with Crystal Instruments Spider front-ends, including the Spider-80X and the Spider-81. Each Spider-NAS device supports up to eight Spider front-ends to collect both streaming time waveform data and spectral data. An Ethernet connection in back connects to a computer for data download and configuration. At the center of the Spider-NAS sits a removable 250 GB serial ATA (SATA) Solid State Disk (SSD). This SSD not only provides greater shock protection than a classic hard drive, but it also features a faster boot up time (less than 15 seconds) and is particularly energy efficient. In a Spider-80Xi chassis the Spider-NAS is installed internally.



United States patent no. 7,302,354



United States patent no. 11,611,946

High Precision Front-end Design

The Spider-80X and Spider-80Xi analog input channels provide extremely high precision measurements. Each channel has single-ended or differential AC or DC input coupling. It can also provide IEPE (ICPTM) input mode (AC coupling with a 4 mA constant current from a 22 VDC source) for use with industry-standard accelerometers with built-in amplifiers. The ability to read TEDS (Transducer Electronic Data Sheet) identification from the attached transducer completes the channel's compliance with IEEE 1451.4. Each channel provides an unprecedented dynamic range of 150 dBFS, detecting voltages as small as 600 nV and up to 20 V. This is accomplished by applying two 24-bit analog-to-digital converters to each channel and combining their outputs in accordance with our **United States patent no. 7,302,354**.

In the Spider-80X, built-in charge amplifiers are available. With Spider-80Xi the external charge amplifier, CA-08, can be used if charge mode is desired.

Black Box Mode

Black Box mode enables Spider-80X/80Xi operation without a PC. In this mode, a PC is used only to configure the control system before the system starts operation and to download data after the test is completed. During the test, the data acquisition system operates autonomously, according to a preset schedule or in response to external events such as input trigger or digital input.

Simple Network Connection

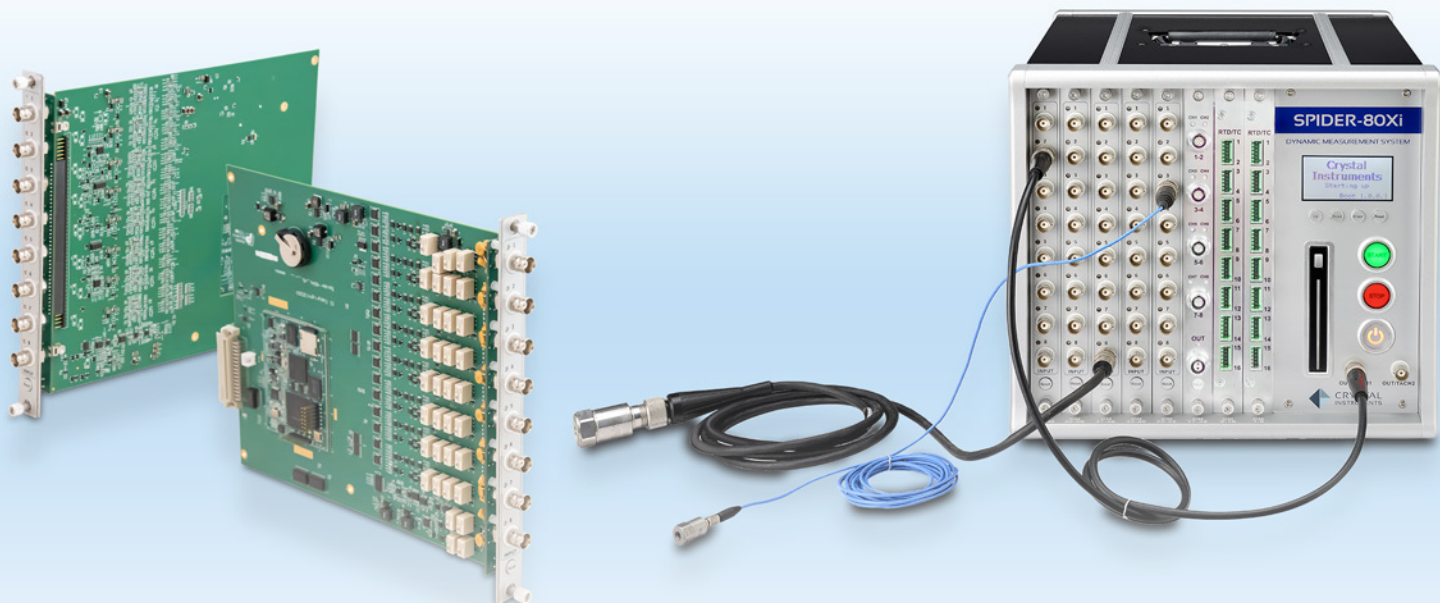
Ethernet connectivity allows Spiders to be located far from their host PC. This distributed structure greatly reduces noise and electrical interference in the system.

GPS Timestamps

Crystal Instruments was awarded **United States patent no. 11,611,946** for GPS time stamping technology. The Spider hardware supports stamping each signal data point with an accuracy of up to 100 ns. Spider devices, not physically connected, can individually be time stamped and post analysis software gives the ability to perform cross-spectrum computations between these Spider modules. Use of GPS timestamping allows for front-ends to be synchronized regardless of distance and without physical connection between units. This feature does not place a limit on the number of front-end units that can be synchronized with GPS timestamping allowing synchronized data acquisition for thousands of channels.

Record to PC

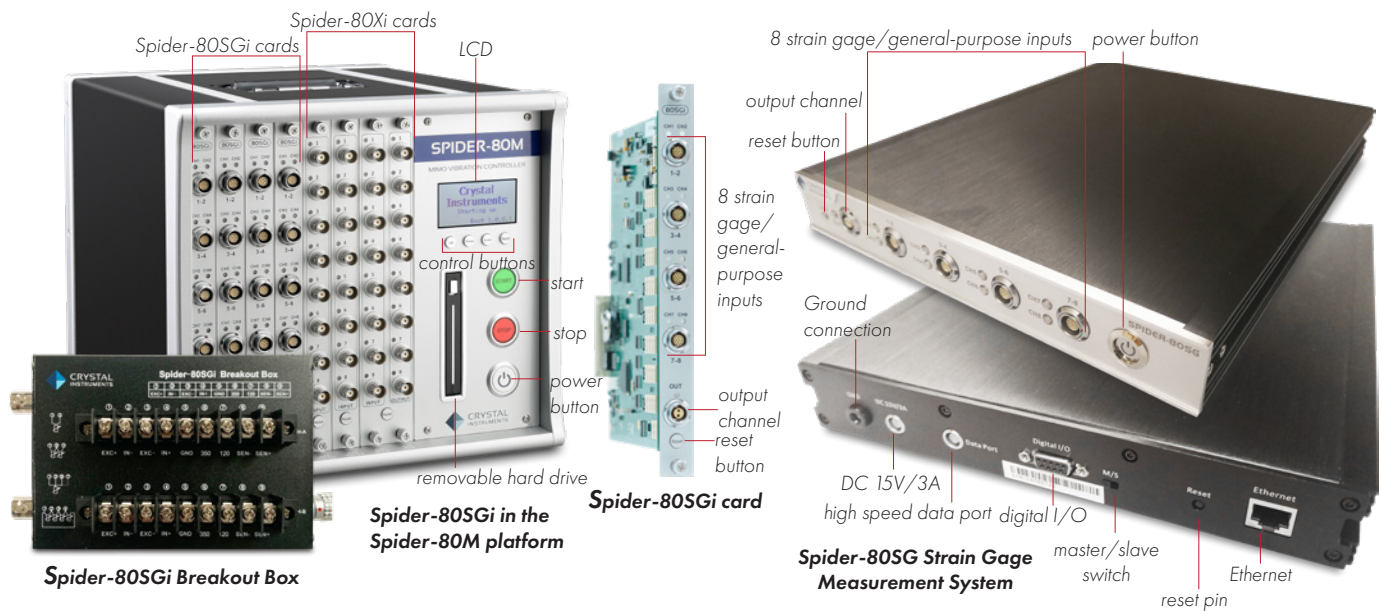
Time streams can now be recorded directly to a PC via USB, eliminating the need to rely solely on the Spider memory or NAS/NASi for data storage. Data can be recorded at a sampling rate of up to 256 kHz for a 64-channel system



The Front-ends of the Spider-80Xi and Spider-80M Platform

Front-end types	Spider-80Hi	Spider-80Ci	Spider-80Gi	Spider-80SGi	Spider-80Ti
Max sampling rate	512 kHz	512 kHz	25.6 kHz	512 kHz	1 kHz
Number of inputs per front-end	8	8	16	8	16
Connector type	BNC	BNC	50 pin D-Sub	LEMO	6-pin pluggable terminal blocks
Input type	IEPE Voltage TEDS	IEPE Voltage TEDS Charge	Strain gage-based sensors	Voltage Strain gage Strain gage-based sensors MEMS DC-based sensors IEPE	3-wire RTD K type thermocouple
Input coupling	AC Differential DC Differential AC Single-ended DC Single-ended	AC Single-ended DC Single-ended	AC Differential DC Differential	AC Differential DC Differential Bridge-Based Sensor	PT 100 (RTD) K, S, T, J, R -Type thermocouples (TC)
Sensor excitation	4.2 mA at 21 V for IEPE	4.2 mA at 21 V for IEPE	+/-2.5 V, +/-5 V	+/-2.5 V, +/-5 V, 10 V 22 V for IEPE	10 μ A to 1.5 mA RTD
Strain gage type	-----	-----	Quarter Bridges (Type I,II, 3 – Wire Quarter Bridge) Half Bridge (Type I,II) Full Bridge (Type I,II) Excitation voltage: ± 2.5 , ± 5	Quarter Bridge (Type I, II) Half Bridge (Type I, II) Full Bridge Type (I, II) Excitation voltage: ± 2.5 , ± 5	
Max input range	± 20 V _{pk}	± 20 V _{pk}	± 10 mV, ± 100 mV, ± 1 V, ± 10 V	± 10 mV, ± 100 mV, ± 1 V, ± 10 V	400 Ohm (RTD) ± 80 mV (TC)
Input protection voltage	± 220 V	± 220 V	± 40 V	± 40 V	-----
Analog to digital converter per channel	Dual 24-bit ADC	Dual 24-bit ADC	24-bit ADC	24-bit ADC	24-bit ADC
Cross talk rejection	Better than 120 dB	Better than 120 dB	Better than 120 dB	Better than 120 dB	-----
Amplitude accuracy	$\pm 0.1\%$ at 1 kHz 1 V	$\pm 0.1\%$ at 1 kHz 1 V	0.1% typical, Less than 1.5% (up to 10 KHz), cable length up to 1000 ft (18AWG)	$\pm 0.1\%$	-----
Phase match	< 1° up to 20 kHz	< 1° up to 20 kHz	< 1° up to 20 kHz	< 1° up to 20 kHz	-----

Strain Gage Measurement



Spider-80SG Highlighted Features

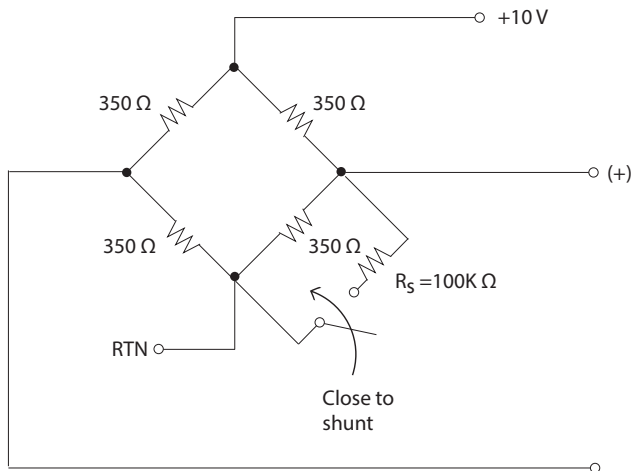
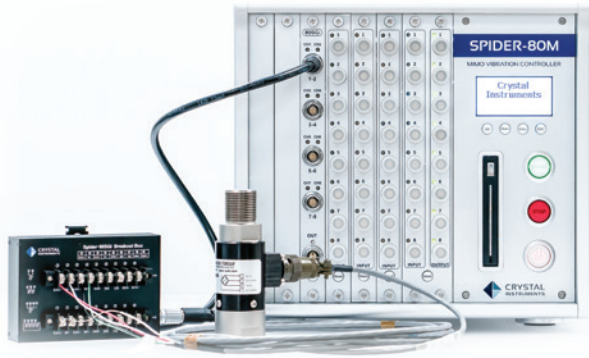
- 8 Strain Gage/General Purpose Inputs per Front-end
- 24-bit ADC Channel
- Supports Multiple Measurement Quantities
- Supports Quarter Bridge, Half Bridge and Full Bridge and Rosette Strain gage Configurations
- Supports a Variety of Strain Gages based sensors, Load Cells, Pressure Transducers, Torque Sensors, MEMS Accelerometers, Displacement Sensors, Velocity Transducers and Geophones
- User Configurable Synchronized Sampling Rate
- Remote sensing: Measures strain accurately from up to 1000 ft cable length with up to 10 KHz frequency.
- Precision Excitation Voltage of ± 2.5 V and ± 5 V
- Power Supply Voltage of 2.5 V, 5 V and 10 V for Sensor Excitation
- Shunt Calibration
- Offset Nulling for any measurement quantity
- Multiple Trigger Modes
- Compact, Portable Design
- Scale up to 512 channels using multiple front- ends
- User selectable sampling rate for each front-end in a high channel count system
- DC Drift: less than 1.5 μ V/V in 48 hours

The Spider-80SG Strain Gage Module

The Spider-80SG/SGi is a front-end in the Spider-80X/Xi hardware family platform. It is a high precision, general purpose data acquisition device featuring strain gage functionality. This device can be used in a variety of physical and measurement tests.

The Spider-80SG can acquire data from a strain gage or a wide range of sensors. With the help of precision excitation voltage, the Spider-80SG/SGi can support strain gage-based sensors, MEMS sensors, and DC sensors (to name a few) thus expanding the scope of the Spider-80Xi hardware platform to support the synchronized acquisition of a wide range of measurement quantities including Force, Torque, Pressure, Acceleration, Velocity and Displacement. It can be used for strain measurement and many other types of sensors that require external power. EDM-DSA and VCS software fully supports the Spider-80SG front-end in all its testing operations.

In addition to the features shared with the Spider-80Xi hardware platform, the Spider-80SG/SGi offers the following capabilities.



High Channel Count

Named for their networkable ability, the Spider hardware platforms (including the Spider-80X/Xi and the Spider-80SG/SGi) share the flexibility of scaling up in channel count and functionality. The Spider-80SG/SGi can combine with any Spider-80Xi device to create a high channel count system with up to 512 channels.

Dual Modes of Excitation

The Spider-80SG is equipped with dual excitation modes. There is an option for Precision Excitation Voltage of ± 2.5 V or ± 5 V that can be used to excite a strain gage or a strain gage-based sensor and to accurately measure the minute change in resistance. It is also equipped with a user configurable DC power supply of 2.5 V, 5 V and 10 V which can be used as an excitation voltage for a wide variety of sensors.

Strain Measurement

The Spider-80SG/SGi supports Quarter Bridge, Half Bridge and Full Bridge configurations for each input channel. It also supports measuring strain through Rosette configurations by combining the user selected channels in the desired configuration.

Remote Sensing

The Spider-80SG has been tested to work on strain gages up to 1000 ft away from the analyzer using the remote sensing feature. Using an 18AWG 5 conductor cable to measure the excitation voltage using remote sensing and changes in output voltage, the error was measured to be less than 1.5% for signal frequencies up to 10 KHz.

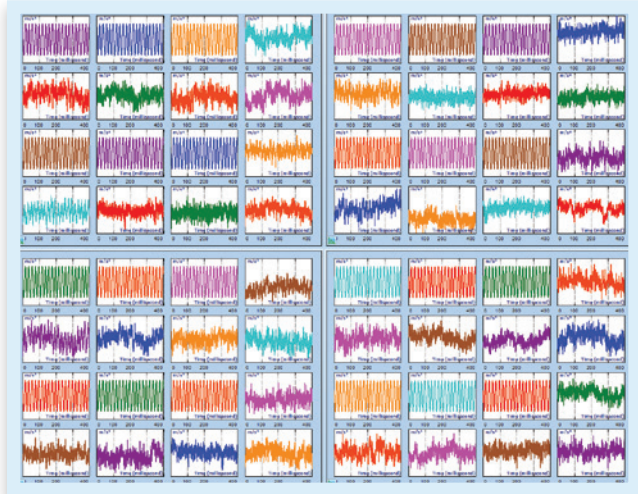
Measurements Quantities and Sensor Types

The Spider-80SG/SGi's user-selectable precision excitation voltage feature enables it to interact with a wide range of sensors, allowing the synchronized acquisition of a wide range of measurement quantities.

Supported Sensor Types: MEMS based Sensors, Strain gage-based sensors, Precision Excitation DC Sensors.

Supported Measurement Quantities: Force, Pressure, Torque, Acceleration, Displacement, Velocity, Sound Pressure.

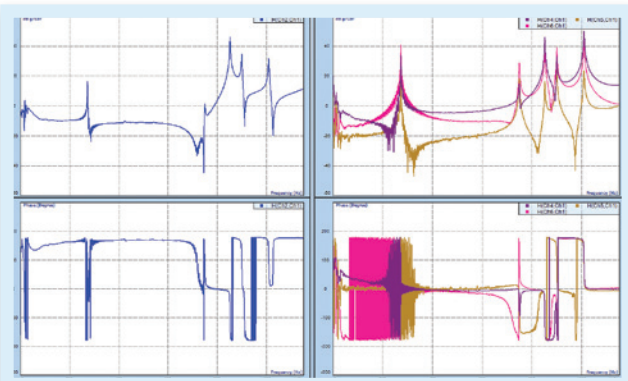
General Data Acquisition & FFT Spectral Analysis



Comprehensive Data Acquisition with Spider System

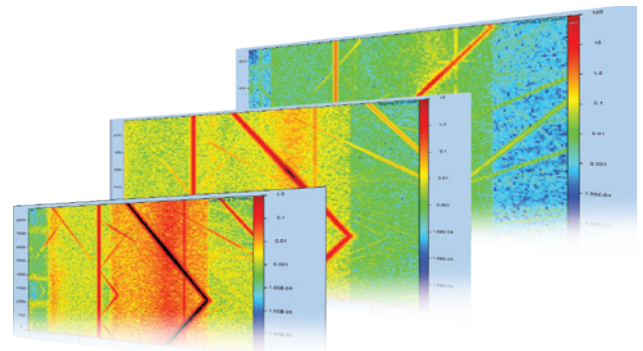
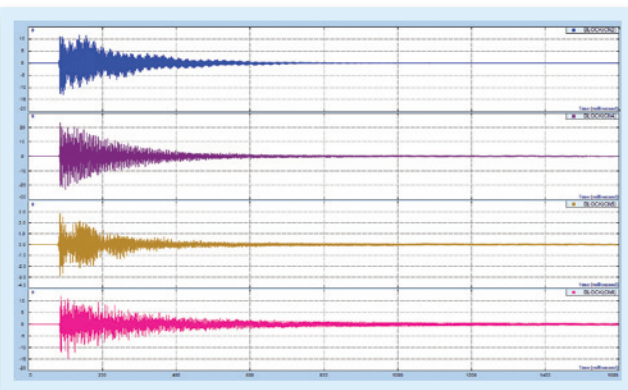
The FFT Spectral Analysis provides comprehensive data acquisition and FFT analysis functions. **Acquisition Mode** controls how the data is acquired block-by-block and processed with the signal analyzer functions. These time blocks can be either gap-free, overlapped, or with gaps, depending on the acquisition mode selection. **Sampling Rate** can be set from the control panel directly. 54 sampling rate stages are available and can be changed without stopping data acquisition. 3D waterfall processing allows the data acquired and processed in real time with either RPM or time as additional axis. Output has a dozen signal source types to excite the testing articles.

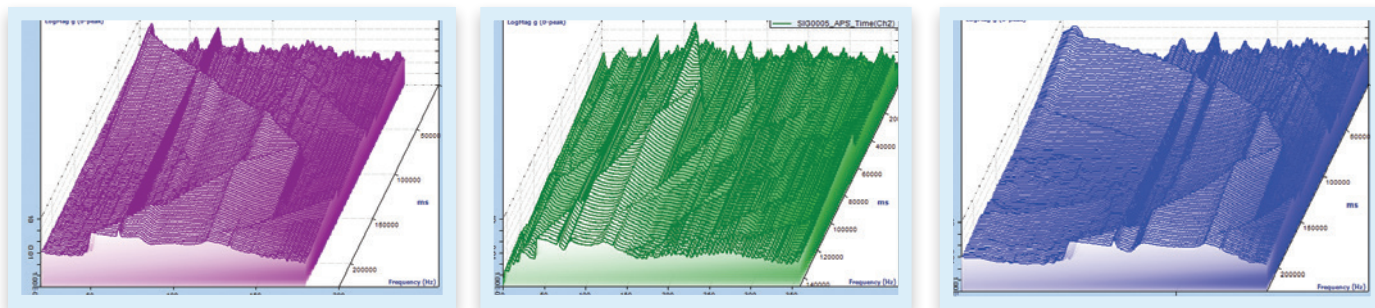
With the **Frequency Analysis Functions** the FFT with block size from 256 to 32,768 for all input channels can be applied simultaneously.



The data window type includes Hann, Hamming, Flattop, Uniform, Kaiser-Bessel, Blackman, Force, Exponential and Force-Exponential. The Spectrum Types include linear spectrum, auto power spectrum, frequency response function, coherence, cross power spectrum and phase spectrum. Hundreds of FRF signals with MIMO model can be computed simultaneously.

With extremely fast DSP, the processing overlap ratio can go as high as 75% or 90%. A special function enables the system to search for the resonant frequency on any FRF signals.





Acquisition Mode includes free-run, continuous after trigger, single shot with trigger, single shot without trigger, auto-arm trigger and manual-arm trigger.

Multi-Resolution Spectrum provides the ability to use different spectral resolutions at low frequencies and high frequencies within the same spectrum. When analysis requires a denser frequency resolution in the lower frequencies compared to the higher frequencies, multi-resolution spectrum can be used. The need for a higher block size (for better frequency resolution) is eliminated because the spectral resolution is eight times higher below the user selected cut-off frequency.

Variable Sampling Rate in the FFT Analysis provides a convenient way to select sampling frequencies of each module in a high channel count system. Measurement quantities such as strain, temperature or pressure often require a much lower sampling rate when compared to acceleration or sound pressure. The variable sampling rate could be efficiently used to select a user defined sampling rate for each front-end while acquiring synchronized data from all channels in the system.

3D signal waterfall displays are available for block signals in all types of tests. 3D signals can be plotted with reference to Time or RPM (when tachometer input is available). User customizable trace number and reference axis settings are available for both Time and RPM reference axes.

With Spider some statistics signals can be computed and recorded into PC with "infinite time". **RMS:** apply RMS estimation to an input data stream and generate a continuous output time stream; **Peak:** extract the peak or peak-peak value over a period of time and generate a time stream.

Math Functions applied to the signals includes operations such as abs, +, -, *, /, square, square-root, log, and offset scale.

Test Sequence creates a list of tests and runs them sequentially. Test sequences can be initiated and controlled by a user command, digital input event, or Windows socket message.

Send Emails and IM as Event-Actions is the ability to send emails or instant messages as custom actions in response to a system or user event. The content of emails can be customized.

Remote Operation Communication using Socket Messages allows you to communicate with and control Spider systems remotely with Window socket messages. Socket messages also allow communication with other hardware, such as temperature chambers. Please refer to the Socket Message document for detailed specifications.

The Spider has strong System Failure Protection. With its **Power Loss Emergency Shutdown**, when a power loss is detected, the system will save all test data into non-volatile flash memory and safely shut down. With its **Ethernet Connection Loss Detection**, when a network loss is detected, the system can be configured to either save all data and ramp down the test or continue running the test in Black Box mode.

Each Spider has 4 pairs of DIO ports which are used to send and receive low level electrical signals to and from other devices to coordinate their operation during a test.

The **output channels** provide signal sources and generate user determined waveforms. Multiple output channels may generate signals independently or simultaneously. The Spider-80X is equipped with two output channels but only one is enabled. An option (S80-P09) is available to enable the second output. Output Types include Sine, Triangle, Square, White noise, DC, Chirp, Swept sine, Arbitrary waveform, Shaped random, Playback

With Spider the software can compute the **SRS** for all channels using maxi-max, maximum negative, and maximum positive analysis techniques. A reference profile is available.

Octave Analysis & Sound Level Meter



The Spider series meets the requirements for measurements from 4 input channels going up to 512 channels!

Acoustic Measurements with the Spider Series

Acoustics measurements are performed for a variety of reasons, including product design, production testing, machine performance, and process control. Crystal Instruments' Spider series has capable acoustic measurement facilities including real-time octave, 1/3 octave filters, and sound level meter functions. Crystal Instruments provides an easy to use yet powerful toolbox for acquiring and viewing acoustic signals. Digital octave band filters and raw time data recording can be performed simultaneously for a detailed investigation of noise problems.

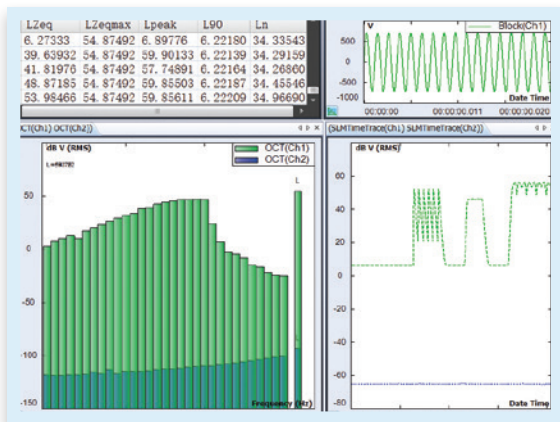
Onboard IEPE (ICP®) transducer power capability allows for direct connection to pre-polarized microphones when used with an ICP microphone preamplifier. Traditional condenser microphones are also easily accommodated by connecting the direct voltage signal from the microphone power supply into an input channel. White and pink noise signals can be produced using the waveform generator. This feature is very useful when performing absorption measurements using a speaker.

Real-time Octave Analysis

The acoustic data acquisition software option for Spider hardware includes real-time octave filters, sound level meters, and microphone calibration functions. These three operations allow users to perform many acoustic measurement operations.

The octave analysis option applies a bank of real-time filters with 1/1, 1/3rd, 1/6th, or 1/12th octave resolution. The input time stream is split into fractional frequency-band signals (octave bands) which can be saved. Frequency weighting can be applied to the octave bands to simulate human hearing, and time weighting can be applied to adjust sensitivity to short duration events. The resulting octave spectra can be saved periodically and displayed on a waterfall plot to observe how the spectrum changes in time. The RMS time history can also be saved as a time trace of a given octave band.

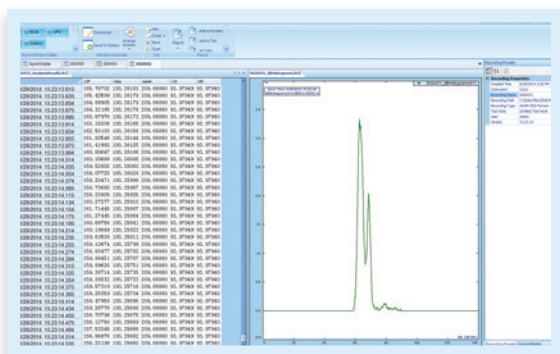
The 1/1 and 1/3 octave analysis is implemented using a real-time band-pass filtering with decimation technique. The data stream is processed continuously and fed into a bank of decimation filters. Band-pass filters are then applied to the output of each stage of the decimation filters. This provides extremely accurate filter shapes that comply with worldwide acoustic standards: ANSI std. S1.11:2004, Order 3 Type 1-D and IEC 61260-1995.



Acoustic Measurement: Sound Level Meter

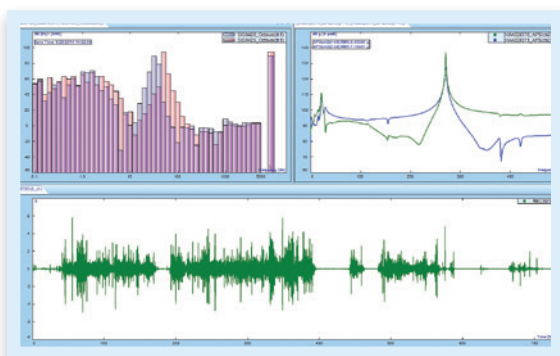
The Sound Level Meter (SLM) is a related application in the acoustic data acquisition software. This module is also referred to as an Overall Level Meter. The SLM applies a frequency weighting filter to the input signal and time weighting to the filter's output. Various acoustic measurements are then extracted from both the input and output signals of this frequency weighting filter.

All of the features that you would expect from an acoustic measurement device are present...and then some! A, B, C, and linear weighting functions; fast, slow, impulse, and peak detectors; and user selectable high and low-pass filtering. The tremendous dynamic range that all Crystal Instruments products offer take the worry out of setting voltage ranges precisely to avoid under-range or overload conditions.



Built-in Microphone Calibration

Microphone calibration is easily handled by using a traditional microphone calibrator together with the online calibration feature. Simply define the frequency and amplitude of the reference signal, and the Crystal Instruments system will automatically detect the input channel that the calibration signal is applied to and then calculate the necessary calibration constants. Offsets are calculated and stored for later reference.

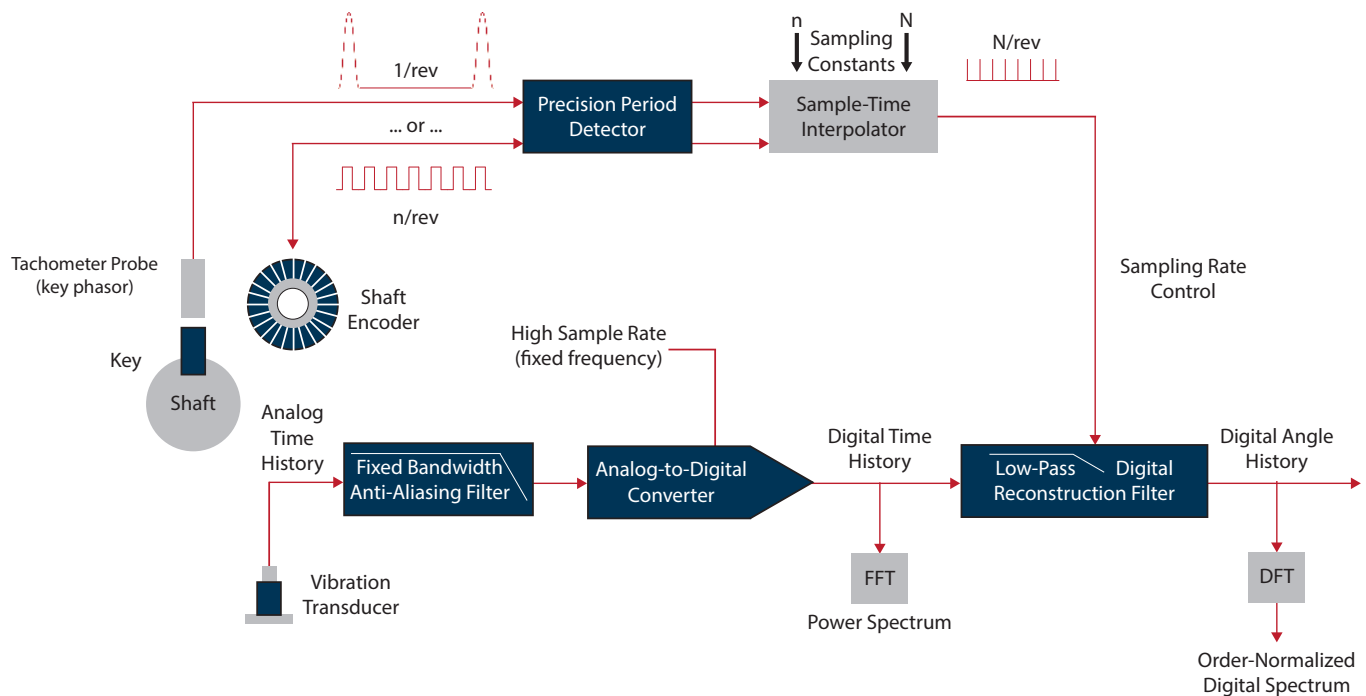


Simultaneous Recording and Octave Analysis

The Spider series is designed with simultaneous time-stream recording capability. While the acoustic analysis is processed in real time, the raw time data of the Spider can be recorded into internal flash memory or an external dedicated Spider-NAS storage device.

The raw time data of all input channels can be recorded at full analysis frequency band. After recording, the saved files can be processed by using EDM Post Analyzer which provides the identical analysis algorithm to those available in the real time mode.

Rotational Dynamic Acquisition & Analysis



Providing Real-Time Order Tracking

The high channel count Spider systems provide a wide range of real-time order tracking capability to understand the noise and vibration induced within rotating and reciprocating machines. Fixed and variable speed machines are accommodated as are both structural vibration and condition monitoring diagnostics. Multiple tachometer inputs can be processed for accurate speed tracking during analysis. Spectral mapping, order tracking, time history and orbit data analysis are all available.

Additionally, Crystal Instruments provides post processing order tracking capability in its Post Analyzer (PA) that generates the same analysis results as real-time order tracking. The user can simply record the raw data together with tachometer signals and process them later.

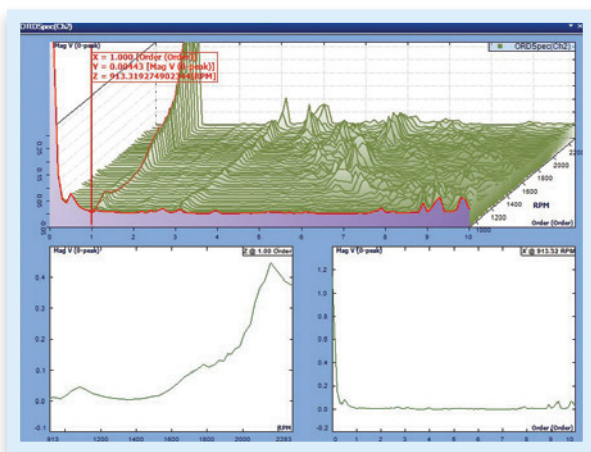
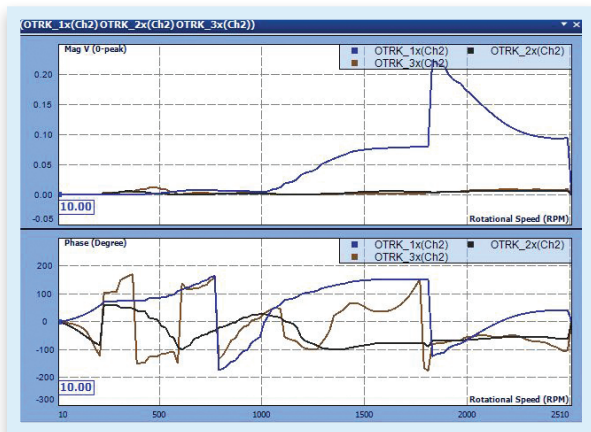
Advanced Digital Processing

All measurements in the order domain are derived from an advanced digital resampling method. High speed DSP processing allows synchronization of the analyzer's sampling rate to a tachometer signal. The analyzer's sampling rate continuously adjusts to track variation in shaft speed. After data sampling, a flexible radix FFT converts the time/angle data into the

frequency/order domain. The flexible radix algorithm provides a much broader choice of resolutions and spans than does a power-of-2 FFT for extraction of the order amplitude values as a function of RPM.

Order tracking extracts the amplitude at a single order and plots it against machine speed (RPM). Real-time order tracking offers advantages over fixed sample rate techniques. It provides better tracking performance when the RPM varies quickly. Additionally, it provides precise control over the order resolution of the measurement. For instance, users can specify that the order resolution be 1/10 of an order for all measurements.

There are also significant benefits in order amplitude estimation provided by the real-time order tracking method. Since the sampling rate is synchronized to the tachometer signal, the data in each frame is always exactly periodic with respect to the fundamental speed. That is, there are always an integer number of cycles for the fundamental and its harmonics in each data frame. Because of this periodicity, there is no need to use a spectral window, such as a Hann window, in the tracking calculation. This results in a more accurate estimate of the amplitude for each order.



Real-Time Order Tracks and Order Spectra

Real-Time order tracks are the amplitude history signals of certain “rotational orders” graphed against the machine’s RPM. Multiple order tracks can be measured, displayed, and saved. Order spectra are auto power spectra that are normalized to orders. All order tracks can have the optional phase which is phase measurement relative to the tachometer signal.

The RPM range can be from 10 to 10,000. The acquisition modes include Free Run, Run Up, Run Down, and Run Up and Down. Run Down and Up order tracks can be scaled with linear peak, linear RMS, or power scaling.

Constant Band Frequency Spectra

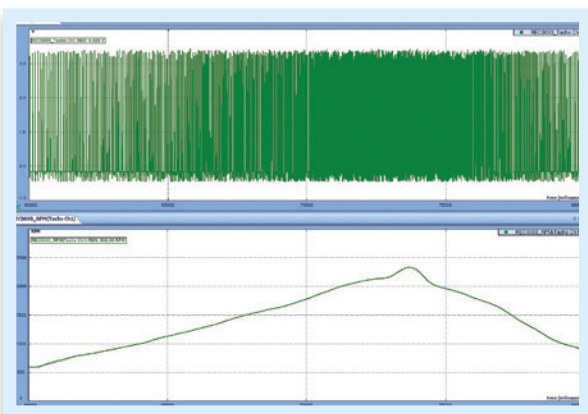
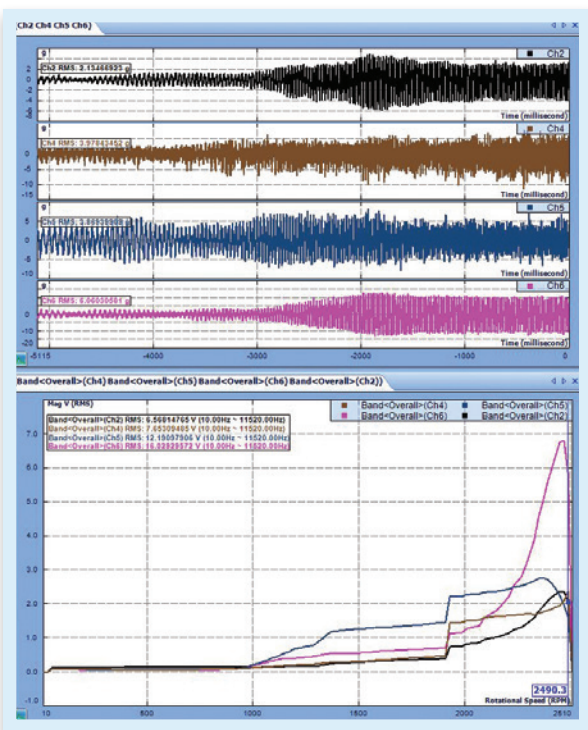
Constant band frequency spectrum displays the auto power spectrum of the selected fixed band of frequencies and is computed using FFT analysis within the fixed band of interest. 3D plots using time or RPM as references are available along with 3D extractions of desired orders of interest. The available spectrum amplitude units include EU_{pk} , EU_{rms} , EU_{rms}^2 , EU^2/Hz , and $EU^2 \cdot s/Hz$

Order Tracks with Phase

Order tracks with phase are order spectra with the associated phase measurement relative to the tachometer signal. All the measurement specifications are the same as real-valued order tracks, except that order tracks with phase can also be displayed as Bode, Polar, or Nyquist plots. Furthermore, with this option the orbit display can be enabled for any two data channels.

Tachometer Processing

The tachometer is stored as a time history. The user may view either the original tachometer input waveform or the resulting RPM-versus-time translation. A tachometer channel can be used to extract the order track of any input channel or channels. Tachometer signal processing automatically eliminates any “glitches” in the tachometer pulse train and reconstructs the best estimate pulse signal for phase measurement.



Orbit Analysis

Online orbits can be displayed and monitored on a standard two-channel orbit diagram chart. For advanced analysis a throughput recording including a tachometer or vibration signal can be post-processed using the orbit analysis tool in Post Analyzer. This provides averaging, filtering and order-based orbit displays with a replay feature for visualizing changes over a change in machine speed.

Display Flexibility

Measurements can be viewed in real time as the data is being acquired and analyzed. On line displays include the time histories, orbit plots, order spectra, order tracks, waterfalls, spectrograms, and contour plots. Users can also view the instantaneous RPM as a function of time.

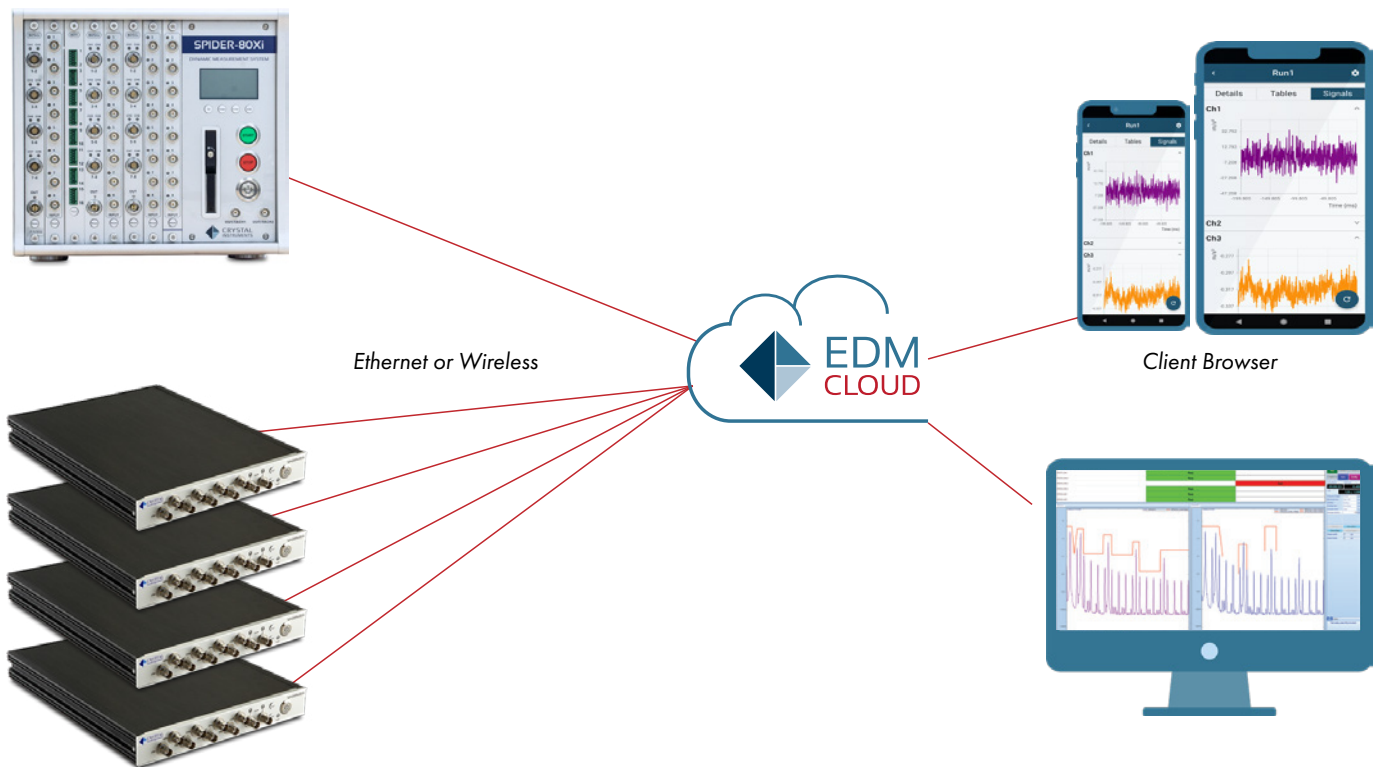
Waterfall displays provide a good overview of an entire run-up or run-down measurement. To better understand the measurement results, users can easily change the viewing angle so that effects of order related excitation and structural resonance excitation are immediately obvious.

Waterfall displays include a "slice" mode that provides a plot of a cut across the order or RPM axes. To view a particular slice, simply position the 3D cursor. Users can view the order track for a given order, or fractional order, or view the amplitude-versus-order spectrum at a given RPM. This capability allows the user to quickly zero in on the problem's root cause.

Color map presentations further enhance problem diagnosis capabilities. For example, spectrograms, or color intensity plots make it very easy to differentiate order related responses from excitation of a structural resonance. Color contours, or topographic maps, also provide added graphic insight into the nature of a vibration or acoustic response.

A full complement of cursors – single, dual, peak, valley, harmonic and sideband provide precise numeric readout of critical data features. Users also have complete and easy control of orientation, scaling, colors, etc., enabling the creation of insightful data visualizations.

Automated Production Testing Solutions



Automated production testing is critical in today's competitive manufacturing environment. Companies can no longer rely on variable costs, non-uniformity, and potential health hazards that come with a laborer-based manufacturing line. This is no less true for sound and vibration tests, ranging from in-process burn-in tests to product validation and verification tests. The measurement tools and intelligence behind present day manufacturing include data acquisition equipment as well as closed-loop control. And while these systems may not take part in the assembly of any goods, they are just as important to ensure quality control for both components coming into an assembly line and products going out.

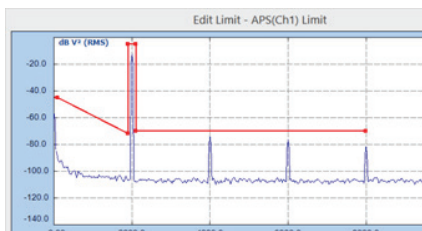
Crystal Instruments has evolved a synergistic solution to such testing involving custom hardware and application-focused software. The Spider-80X and Spider-80Xi systems are complete multi-channel analyzers and controllers with IEEE 1588 Precision Time Protocol (PTP) Ethernet communication. The Spider systems can be programmed to accomplish multiple

complex measurement tasks using a workstation or PC running Engineering Data Management (EDM) software. Through EDM, the user can create custom interfaces and greatly simplified operating interfaces for specific product tests. Users can also generate custom reports using XML, OpenOffice, PDF, and Microsoft Word templates.

The PC can (optionally) be disconnected and tests run in "Black Box" mode without an attached computer.

Black Box mode provides the ability to run Spiders without an attached computer. Control of the Spider may be accompanied through an Apple iPad tablet using the EDM App for iPad. The Spider API, when used along with Black Box mode, is the gateway to integration with LabView, Mat-lab and other scripting software. Spider front-ends operate from Android, Linux and iOS in addition to Microsoft Windows. A single iPhone, tablet or PC can control multiple Spider front-ends at distributed locations running disparate tests from a single control screen.

Step 1:
EDM sets the alarm limit together with a special message string, such as "Exceeding Limit".

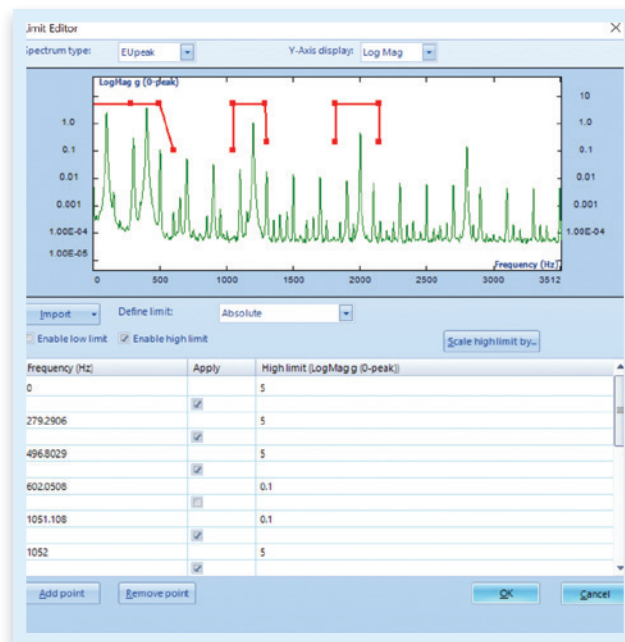


Step 2:
When an alarm event happens, the customized string, "Exceeding Limit" will be sent to the EDM Cloud email service.



Step 3:
User will receive an alarm email

EDM or EDM
Cloud Email
Service



Limit Configuration

Alarm limits could be defined independently, and multiple limits could be defined to each channel and may be applied to a Time Block, Auto Spectrum, FRF, Coherence, Octave Spectrum, Sound-Level Measurements, RMS, or Peak value. Spectra and time histories are tested by comparing against a custom test signal; a template which must bound the measured signal. Each test signal may be either an upper or lower limit and may contain up to 64 segments. Up to 64 test signals may be applied to a single measurement.

Customize Actions for Specific Events

Event-Action Rules (EAR) allow users to customize the system's response to every test event. User defined events include: signal exceeds a limit profile, signal is less than a limit profile, normal end-of-test, loss-of-signal or any of number of the events encountered during a VCS test. Responses include: halting a test, starting a different test, flashing the control screen, initiating a recording, sending a screen message, sending a text message, or sending an email. Users can program loops using EAR. Every event is logged on a cloud server and is identified by the text of a customized event string (only on EDM Cloud).



Spider-HUB, Spider-NAS, and Spider-80X stacked together

Auto Failure Detection

Defining the limits on either time or spectral data enables the Spider system to compare the input signal with the defined Pass/Fail tolerances and instantaneously display the status on the EDM. This feature is particularly useful during Burn-in tests. For example, consider cell phones, a consumer product produced in the thousands which contains both a microphone and a speaker. These two audio components almost always need to be run through a burn-in test, which is easily automated using the Spider platform of products. The Spider provides a stimulating programmable function generator using the output channel and data is collected from the input channels which is then compared with the tolerances to detect the failed products.

However, burn-in tests are not the only type of automated production tests performed with sound and vibration instrumentation. Product validation and verification are also an important part of production line testing. Such tests range from validating incoming components to verifying a finished product assembled from them.

Virtually all turbine manufacturers carefully match tune the component blades of their steam and gas turbines. This involves

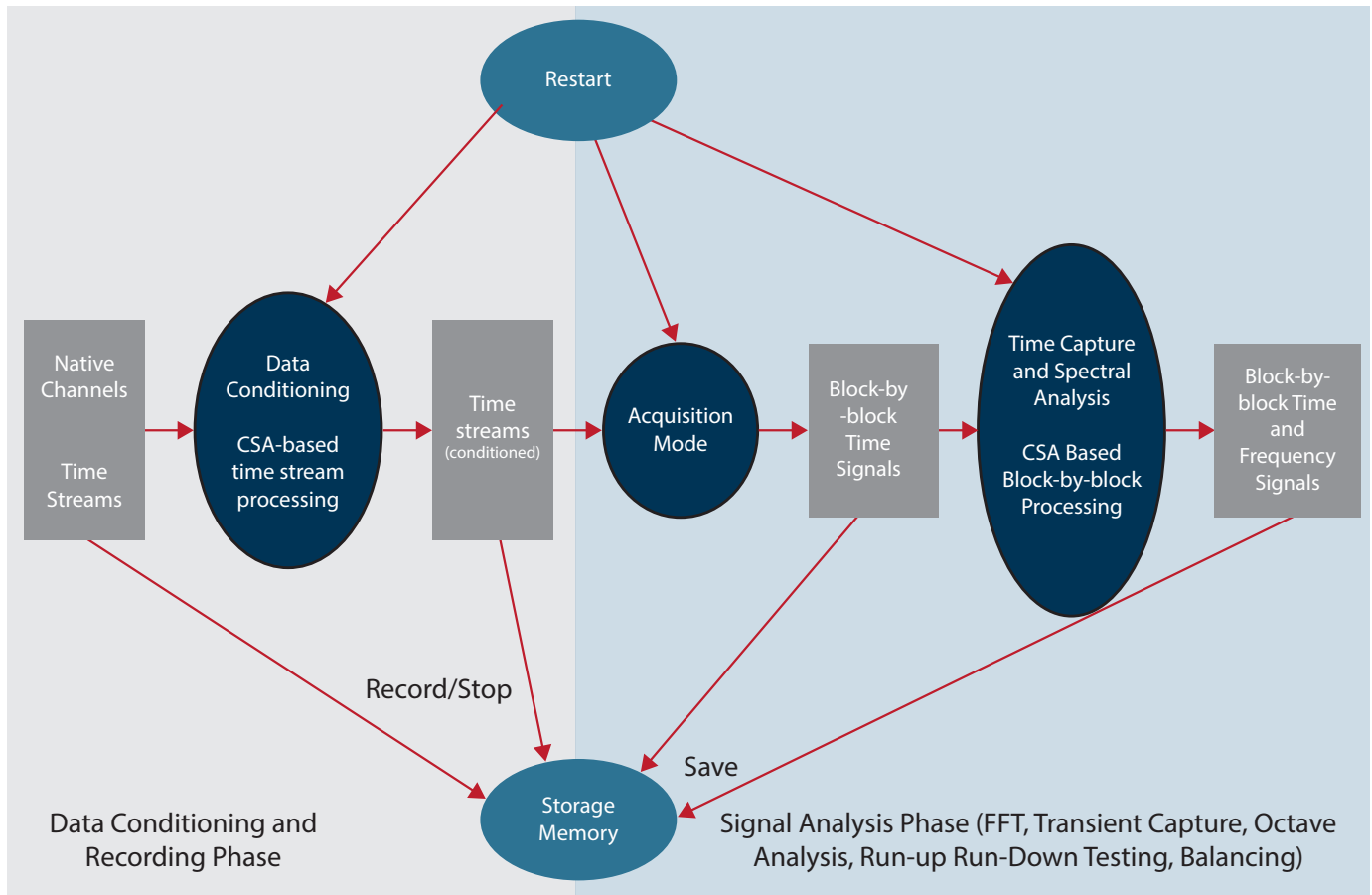
accurately measuring the natural frequency of one or more vibration modes of each blade individually, while the blade is root-restrained by a standardized fixture. Different manufacturers implement such tests in various manners, but all rely upon measuring the forced vibration response of the blade. The most accurate frequency determinations are made from frequency response functions (FRF), wherein both the stimulating force and resulting vibration are simultaneously measured.

Frequency response functions characterize the linear relationship between a measured input and output and convey an enormous amount of information. An accompanying two-channel measurement, the coherence function, determines if two signals are linearly related. It is an ideal indicator of throughput linearity, an important characteristic of most electronic circuits and many mechanical structures.

Scalability

Scalability is one of the benefits of automation and this is why the Spider-80X/Xi is designed as a networked device. With an Ethernet connection on the Spider-80X/Xi, multiple front-ends are connected to test tens if not hundreds of products simultaneously.

Continuous Data Recording & Post Analysis



Introduction

In a time-critical test, it is highly desirable to record the raw time data continuously, so that the data can be analyzed later when more time is available for a complete review. Integral raw data recording eliminates the need for a separate recording device so necessary just a few years ago.

The Spider platform simultaneously performs both real-time processing and continuous data recording. In most real-time applications, the raw data can be recorded at any desired sampling rate with full 32-bit floating point precision. To increase the reliability of data recording, a special check sum algorithm is always applied to the measurements.

For example, in a typical FFT process the raw data time streams (full bandwidth, sampled at the instrument's highest sample rate) and/or the continuous output of a bandwidth-reducing data conditioning process can be recorded at a lower sample rate on the system's storage media while the real-time filtering and spectral analysis is in progress. This same design philosophy is incorporated in the Spider high channel count systems.

While being recorded, the measured values can be graphically displayed as y/t or y/x diagrams, as bar charts, as waterfalls, FFT, PSD, tachometer speed, or numerical statistics displays with a simple mouse-click. EDM software allows users to design an individual graphical visualization for each desired real-time measurement.

The recording system processes virtually every physical quantity, including: temperature, voltage, stress, strain, pressure, force, acceleration and frequency. Even high channel count applications using hundreds of channels can be configured within a very short time and are handled safely and efficiently.

The recording function is driven by user-defined events. On Spider front-ends the recording "action" can be initiated via various events, including: hard button press, user software command, defined trigger-condition event, digital input event, third party software command, defined alarm limit event, fixed timer, etc.

Typical Data Storage on the Spider-NAS

General Functions

- NTFS file system: Supports single large data file (2 TB max)
- Data format: ASAM ODS data format
- Data samples are in 32-bit single precision floating point
- Data file access: EDM, FTP, removable disk
- Configuration Tool: EDM software from Crystal Instruments

Storage Speed

- Up to 64 channels, each sampled at up to 256 kHz sampling rate retained with 32-bit floating point format (per IEEE 754-2008)
- Aggregate speed is greater than 26 MB/second

Typical Storage Duration for a 250 GB Disk

- 4 channel at 1 kHz/ch sampling rate: 4660 hours
- 8 channel at 5 kHz/ch sampling rate: 466 hours
- 8 channel at 102.4 kHz/ch sampling rate: 23 hours
- 64 channel at 102.4 kHz/ch sampling rate: 3 hours

Management

- Wake-on LAN, Keyboard Power-on, Timer Power-on
- System power management, AC power failure recovery
- Watch Dog Timer

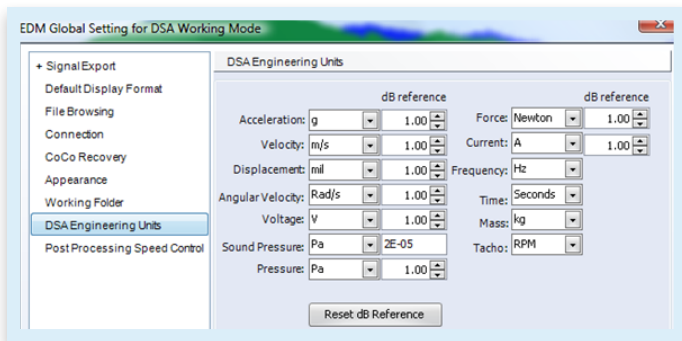


Spider-NAS (Network Attached Storage) dedicated storage device

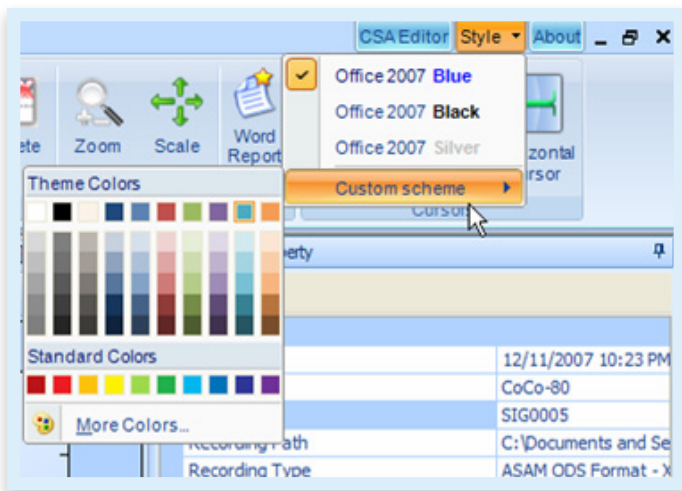
High Channel Count System with Spider Front-ends

For high channel count applications, the data recording can be realized on Spider systems via either of two approaches: record the time-stream data into the flash memory on each of Spider front-end or, record the time-stream data into an external storage device, such as the Spider-NAS. (One Spider-NAS can service up to eight Spider-80X data acquisition front-ends simultaneously.) Either way, the data recording path does not involve the system's Ethernet connection. This provides robust recording while preserving network communication bandwidth.

The Spider-NAS (Network Attached Storage) is a dedicated storage device that works with front-end modules from Crystal Instruments, including the Spider-80X, Spider-80SG, Spider-81, and Spider-DAQ. Eight dedicated high-speed data buses interface directly with each Spider front-end. Each Spider-NAS dedicated data port communicates at speeds up to 480 MB/second. The Spider-NAS can store simultaneous data from all (64 maximum) attached dynamic measurement channels at a sample rate as high as 256 kHz, or as low as a few samples per second. An Ethernet port is used to configure and control the Spider-NAS.



Customizable Engineering Units: Since the data model is built on ASAM-ODS, signal engineering units are carefully handled. The user displays the signals with user selectable quantity and units.



Customizable Styles: EDM is built completely upon the Microsoft.NET technology. The user interface has a modern look and is customizable per individual preferences.



CoCo-80X Dynamic Signal Analyzer

Remote Operation on Recorded Data

The recorded data can be remotely accessed and downloaded to an authorized PC anywhere in the world. This feature is particularly useful for remote machine monitoring or structure health monitoring. Multiple Spider front-ends can be installed throughout a processing factory or at a single machine location. The vibration signals and their extracted characteristic values can be recorded continuously.

User Interface

EDM is PC software offered by Crystal Instruments to manage Spider or CoCo front-ends in single or multiple configurations. The physical connection is made through either USB or Ethernet. The EDM software intelligently searches through the connected hardware devices and browses into the remote device to look at its hardware property or software files. Data files are downloaded by drag-and-drop. The user is able to download multiple files and to view the files simultaneously.

EDM is also used as a terminal to configure Spider and CoCo devices. Project files are uploaded with one mouse click.

Post Processing

EDM Post Processing includes a convenient tool to browse through raw data files and make selections for additional post processing. The selected time data is then analyzed using the CSA technique where the process is created using graphic functional elements designed for filtering, spectral analysis, and time-frequency analysis.

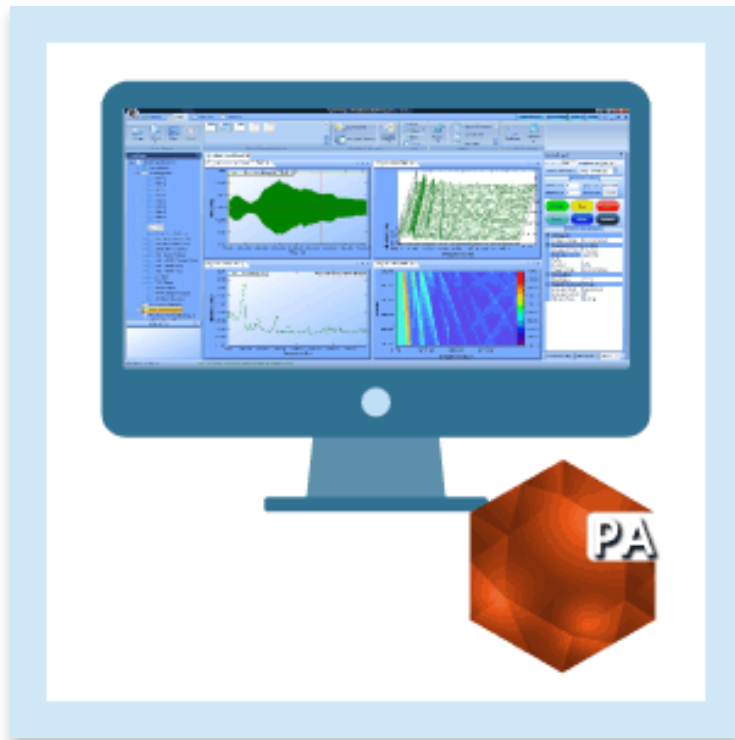
Data File Browsing and Selection

A unique algorithm is developed to help users quickly browse through any segment of raw data files even when the files include gigabytes of data.



Spider-80X Dynamic Signal Analyzer

EDM Post Analyzer Software



Crystal Instruments offers EDM Post Analyzer software, a powerful adjunct to your Spider-based analysis tool kit, allowing you to analyze Time Stream recordings made using your Dynamic Signal Analyzer. The beauty of this approach is that it lets you analyze and reanalyze digitally recorded data after the recording event.

Recording first and analyzing second makes great sense to first-responding problem solvers. Simply recording does not require all of the tactical measurement decisions to be made before data is taken. Often a new problem requires some “get acquainted” measurements to really define the difficulty and its root cause. We are often not smart enough to guess what causes our new challenge. We need to look at some representative measurements from different analytic viewpoints to begin to understand the problem and home in on its solution. The approach is eminently suitable for a team effort. A recording technician can acquire data using minimum equipment while the analyst can remain on post with his analytic workstation.

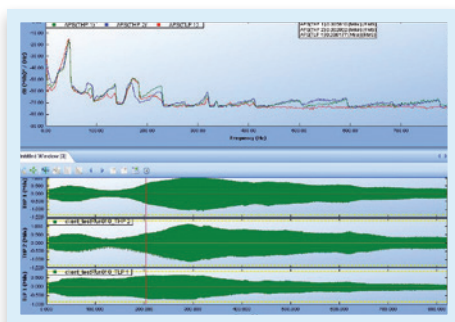
To offer a complete package of both real-time analysis and post processing, Crystal Instruments developed three separate but related software modules: Post Analyzer, Waveform Editor, and File Converter. Post Analyzer (PA) contains many powerful post processing tools with batch processing capability. Post Analyzer is an independent Windows application that analyzes recorded

data files on a computer using various algorithms. Most of the algorithms implemented in PA are identical to those used in the real-time DSP of the Spider hardware. The user should expect the same or very similar calculation results using PA to those computed in the hardware in real-time. This document describes the PA functions.

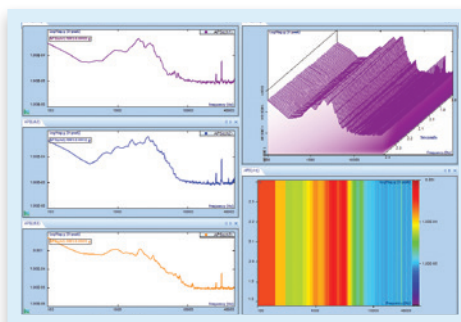
Waveform Editor is an independent Windows application that allows the user to cut, edit or merge the time waveforms. File Converter is an independent Windows application that converts files in various data formats to standard ATFX format.

For convenience of ordering, we also created two bundles of PA: PA Basic allows the user to view or export data and create reports as well as conduct FFT spectral analysis, curve fitting, demodulation spectrum and display 3D signals; PA Premium has more advanced functions including Waveform Editor, File Converter, offline sine reduction, real-time filters, octave filters and order tracking.

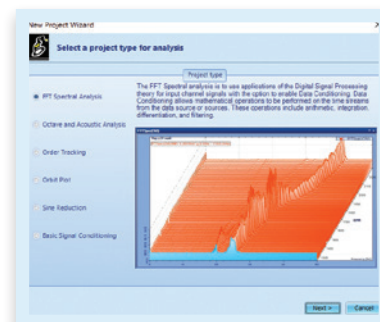
Engineering Data Management (EDM) is a complete suite of turn-key solutions for both real-time processing and post analysis. Shown in the next page are typical screen shots of EDM PA functions, in the following order: Post Processing, PA Spectra, and PA Projects.



Post Processing

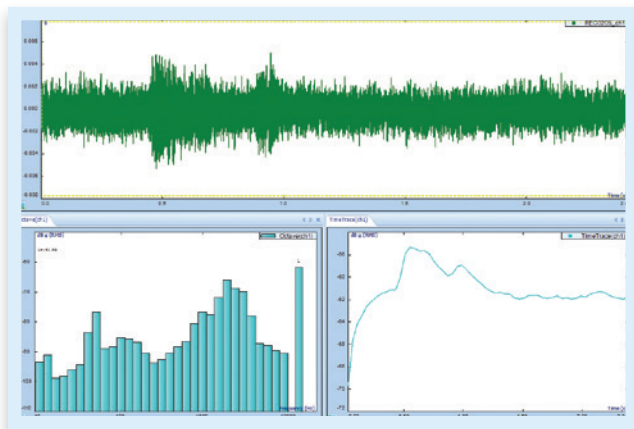


PA Spectra



PA Projects

Function	PA Basic	PA Premium
Browse, display, and edit long waveform files	✓	✓
Signal display with different spectrum unit and X-Y scale	✓	✓
Signal annotation, cursor, play sound, calculate RMS, THD, ZOOM-in, ZOOM-out, auto scaling	✓	✓
Create template-based report in HTML, Excel, Word or PDF	✓	✓
Engineering unit conversion, dB reference	✓	✓
Export to standard formats including ASAM-ODS, UFF, BUFF, MATLAB, user-defined ASCII, and wave files	✓	✓
3D display: waterfall, colormap	✓	✓
Import user-defined ASCII file, wave file, Pacific Instrument file	✓	✓
Acceleration, velocity and displacement conversion	✓	✓
Polynomial Curve Fit	✓	✓
FFT Spectral analysis: FFT, auto power spectra, cross power spectra, frequency response function	✓	✓
Math Functions: abs, +, -, *, /, square, square root, log, integration, differentiation, RMS, peak, offset and scale		✓
User defined data conditioning modules (PA-05)		✓
Digital Filters: IIR, FIR, Low-pass, High-pass, Band-pass (PA-06)		✓
Shock Response Spectra (SRS) (PA-07)		✓
Fractional octave filters and SLM: 1/1, 1/3, 1/6, 1/12 (PA-08)		✓
Order Tracking: RPM spectra, order spectra (PA-09)		✓
Offline Sine Data Reduction (PA-10)		✓



Contact sales@go-ci.com to order or visit www.crystallinstruments.com to find a local distributor.

EDM Post Analyzer Ordering Information

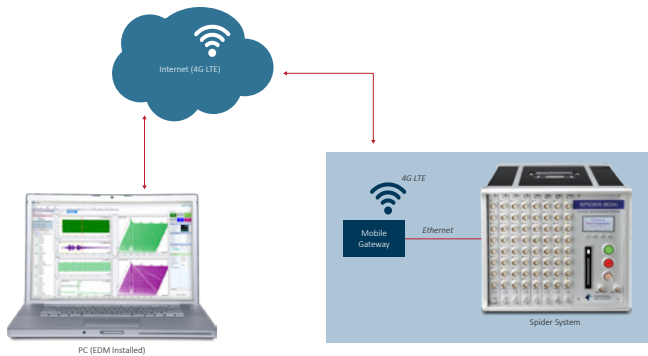
EDM - PA Software

Part Number	Description
PA-05	User Defined Signal Conditioning
PA-06	Digital Filters and Resampling
PA-07	Shock Response Spectrum
PA-08	Octave Analysis and SLM Analysis
PA-09	Order Tracking and Rotating Machinery Analysis
PA-10	Offline Sine Data Reduction
PA-11	Fatigue Damage Spectrum
PA-12	Time Stamped Signal Processing for data acquired by CI-GRS

EDM - PA Bundles

Part Number	Description
EDM-01	PA Viewer: View data, export data to UFF, BUFF, MATLAB, user-defined ASCII, and wave files. Generate reports. Option is included with all CoCo or Spider purchases. Includes File Converter and Waveform Editor.
EDM-02	PA Basic Bundle: In addition to functions of PA Viewer, PA Basic includes 3D display, File import, File export, trigger, FFT post-analysis.
EDM-03	PA Premium Bundle: In addition to PA Basic, PA Premium includes signal conditioning, digital filter and resampling, SRS, octave analysis and SLM, order tracking, offline sine reduction.

Wireless Condition Monitoring



Hardware and Software Solutions

Sometimes a test conducted at a proving ground in Michigan needs to be controlled by engineer in California or a wind turbine in Germany requires observation by designers in Japan or vibrations on an orbiting space station need to be remotely evaluated. That's when remote condition monitoring is the tool of choice. A Crystal Instruments Spider system remotely deployed can be wirelessly linked to a PC in an office which is running EDM-RCM (Remote Condition Monitoring Software).

EDM-RCM provides a convenient interface to setup multiple single and high channel count systems and simultaneously monitor all the systems together.

Monitoring Using Cellular Networks

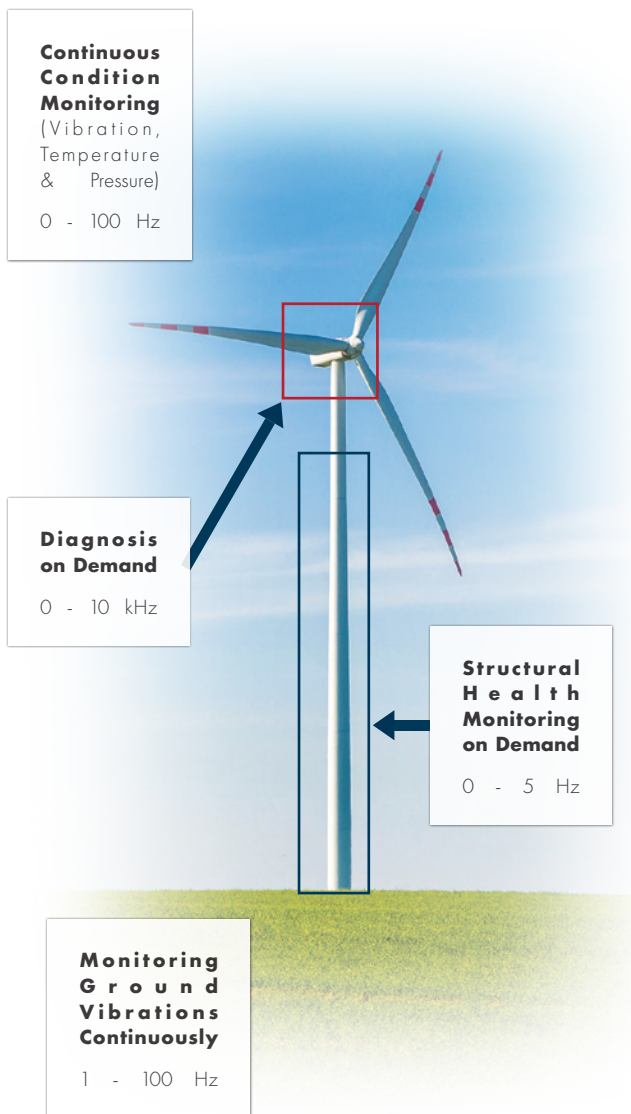
Wireless service providers have expanded rapidly to support world wide connectivity.

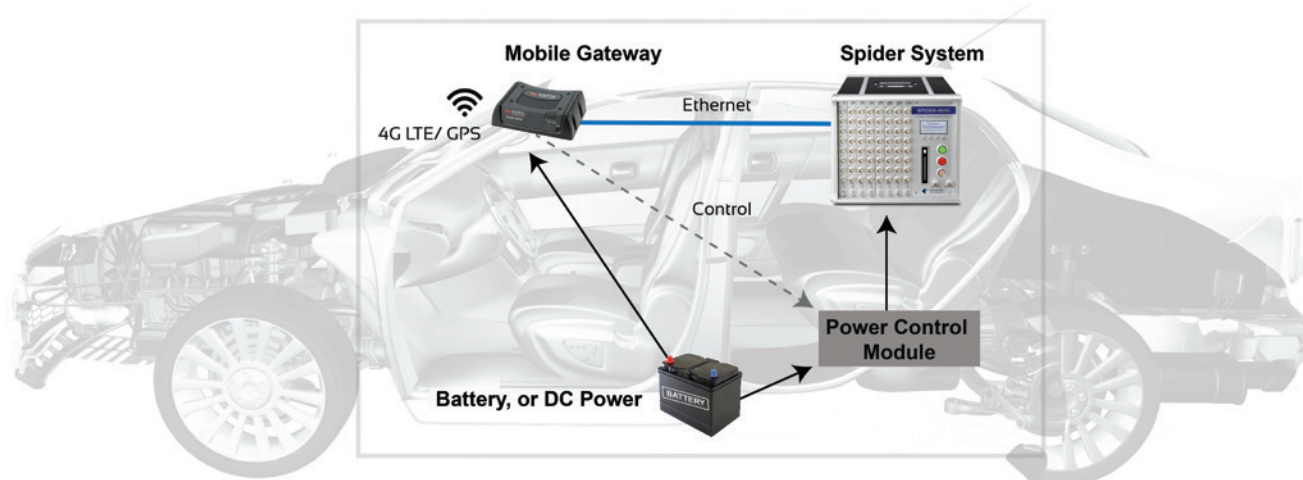
In the United States, cellular carriers such as Verizon, AT&T and Sprint have covered the most populated areas of the country with 4G LTE technology and the transmission bandwidth can easily reach to 10 to 20Mb/s. Other developed countries have wireless networks that reach and surpass that of the United States' and even developing countries are rapidly expanding wireless internet connectivity.

This means that a Spider system placed in a moving car can be remotely monitored and controlled by a PC with an internet connection running EDM-RCM software. The Mobile Gateway modem makes the remote in-vehicle operation of Spider system possible. Crystal Instruments has developed several competitive features that help its line of Spiders succeed at wireless remote condition monitoring.

Using the powerful "Black-Box" mode feature of the Spider, the PC merely acts as a terminal to view the status. If the connection fails or slows due to limitations in the transmission, such as the wireless connection becoming bad, neither the data acquisition nor the monitoring functions on the Spider system will be interrupted.

The design function resilience of the Spider system assures that no external failures will compromise its smooth operation.





Remote Condition Monitoring Features

- Simultaneously monitor status of multiple Spider systems
- Simultaneously download data from all Spider systems
- View generated alarms across all Spiders
- Low Power Consumption
- 160 dbFS Dynamic Range
- "Black Box" Mode (No PC Required)
- Reliable in All Circumstances

Power consumption is a big concern for remote monitoring and the Spider excels in this area. A Spider has an internal flash memory that stores all the software code, configuration parameters and the measurement data. This design runs the system at a low power consumption. A typical Spider-80X unit, which can acquire data at 256 kHz with 8 inputs will only consume about 10 watts of power and a four input Spider-20E only consumes about 6 watts.

Monitoring Over LAN

Using the capabilities of the Spider's Black Box mode together with the ability of EDM-RCM to efficiently monitor multiple Spider systems simultaneously, the Spider systems could be deployed in a plant or a factory where continuous monitoring of several machines are needed.

Each Spider front-end is configurable to continuously monitor the input channels and can be set to save data or generate specific events when certain user defined limits on time or spectral data is exceeded. The generated alarms are then passed to the EDM-RCM software for the user to diagnose.

Remotely Manage Power to a Spider System

The active power consumption of one eight channel Spider front-end is less than 10 watts. It is feasible to use battery power, or solar assisted power source to power the units.

In the events where the Spiders need to save power when data acquisition is not needed, users can put the system into power saving mode using an intelligent power control module developed by Crystal Instruments. The power module uses Ethernet messages which can be transmitted to the Spider using a local network or through the internet. The power module can also be used to remotely power cycle the Spider.

Versatile Report Functions



Fully Customizable - Generate Reports Quickly & Easily

In the EDM software, the report function allows users to create a report in several formats including OpenOffice, XML, Microsoft Word, ActiveX and PDF. The report is template-based and completely customizable.

Users can customize the logo, margins, orientation of the paper, font, and content. Microsoft Word/Office does not need to be installed in order to create reports. In Review Mode, batch reports can be made for the signals saved in multiple runs. Using ActiveX reporting, signal displays in the report can be rescaled, analyzed, and zoomed.

Users can select from various templates for creating reports

- Plot reports can be generated by simply right-clicking the mouse
- Company logos can be inserted into the template header or footer
- Reports can be in WORD, XML or PDF format
- "Active Report" allows the user to ZOOM in and out like a graph on the report
- Generate typical hardware calibration reports

Comprehensive Technology Service Agreement

www.crystalinstruments.com/technology-service-agreement



Crystal Instruments understands the enormous investment our clients put into our products. We match their investment by offering the most comprehensive technical support agreement in the industry. From support calls to staff training, Crystal Instruments provides solutions to our customers' needs.

The "Comprehensive Technology Support Agreement" offered by Crystal Instruments is fairly priced as a small percentage of the total purchase value. The services offered and included in the agreement are for the duration of 1 year. The agreement is renewable at a locked in rate as a subscription. Rates are subject to increase if a subscription is not continued at the time of renewal and signed up for at a later time. Please contact Crystal Instruments for pricing information.

Services offered are:

- Annual software upgrade program - accessible by convenient online downloads
- Annual hardware calibration
- Priority phone/email/live video support from highly trained engineers
- Temporary replacement unit for hardware in 48 hours
- Data recovering services
- Hardware repair when the total service hours required is less than 4 hours per incident

Annual Hardware Calibration

Crystal Instruments DMS is certified by ISO:9001. Hardware calibrations are also performed at the customer's site upon request. Customers with a Premier Technology Service Agreement will receive standard annual hardware calibration services at no additional cost (a \$1500 value).

Annual Software Upgrades

Crystal Instruments provides convenient solutions for software upgrades. Users are able to download the latest versions of Crystal Instruments' Engineering Data Management (EDM)

software through the support website.

Other options include emailed links to download software updates, physical CD-ROMs sent to your location, and installation instructions provided over the phone by our highly qualified Applications Engineers. Customers with a Premier Technology Service Agreement will receive standard software update services at no additional cost.

Temporary Replacement Units

Crystal Instruments strives to minimize any inconvenience to our customers' operations. Temporary replacement units are often provided to customers as a solution. Units will usually be assigned to customers within 48 hours or less.

Live Product Support

Crystal Instruments support staff is based in Santa Clara, CA at our corporate headquarters. Our support staff provides phone and email support from 8am to 5pm PST, Monday through Friday. All support is provided by highly trained engineers, not technicians. After hours support is also available upon request.

Crystal Instruments' highly diverse staff provides native language support in English, Spanish, Mandarin, Cantonese, Japanese, Taiwanese, Persian, Hindi, and Vietnamese.

Hardware Repair Services

Crystal Instruments provides hardware repair for units estimated to have a 4 hour or less repair service period. Additional hours required for repairs are charged at an hourly rate. Replacement parts are discounted by 30% under the Premier Technology Support Agreement. All hardware repair takes place at Crystal Instruments headquarters in Santa Clara, CA. Our highly trained technicians will accurately and efficiently repair your equipment in our ISO:9001 certified facilities.

Data Recovery Services

Crystal Instruments understands the importance of recovering any lost data safely and securely. Our staff is ready and available to assist you through any data loss crisis.

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